Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination VANEPPS ET AL.	
10/723,776		
Examiner	Art Unit	
Christian A. Hannon	2685	

SEARCHED					
Class	Subclass	Date	Examiner		
455 455	567 550.1	3/1/96	CH		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Consulted w/ Q. Vuong	3/1/02	H			